

**Search Notes**

Application/Control No.

10/607,594

Examiner

Tim Phan

Applicant(s)/Patent under  
Reexamination

MIYA ET AL.

Art Unit

3729

29/596

**SEARCHED**

Class	Subclass	Date	Examiner
29	596	11/23/2005	TP
	566.1		
	597, 598		
	732, 736		
242	432.6		
310	71, 90		
	216		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search Attached	11/23/2005	TP